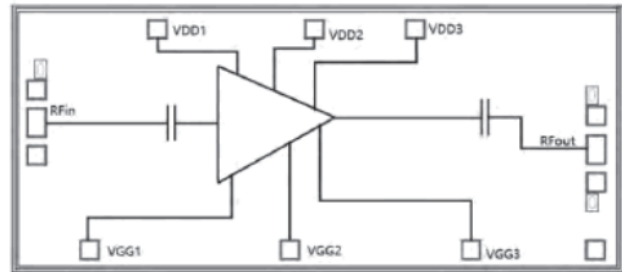


Features

- Frequency: 12-17GHz
- Gain: 28dB
- Noise figure: 2.5dB
- P1dB: +25dBm
- Power supply: +5.0V @200mA
- Die Size: 3000 x 1290 μm

Functional Block Diagram

Typical Applications

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

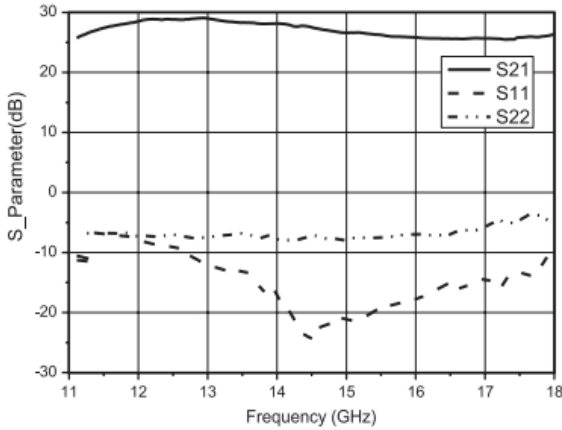
Electrical Specifications

TA = +25°C, Vdd = +5V, Vgg = -0.8V

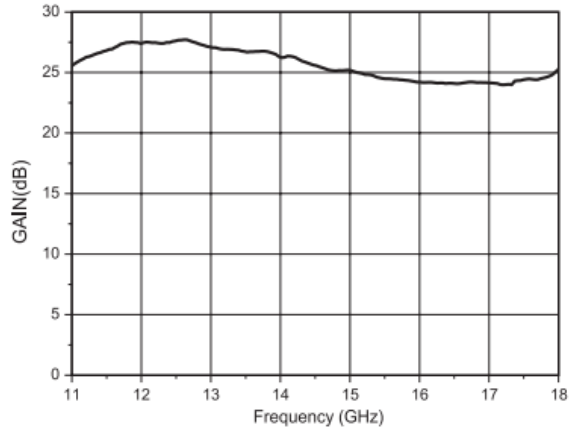
Parameters	Min.	Typ.	Max.	Units
Frequency	12-17			GHz
Gain		28		dB
Noise figure		2.5		dB
P1dB		25		dBm
Input Return Loss		15		dB
Output Return Loss		7		dB
PAE		30%		
Operating Current		200		mA



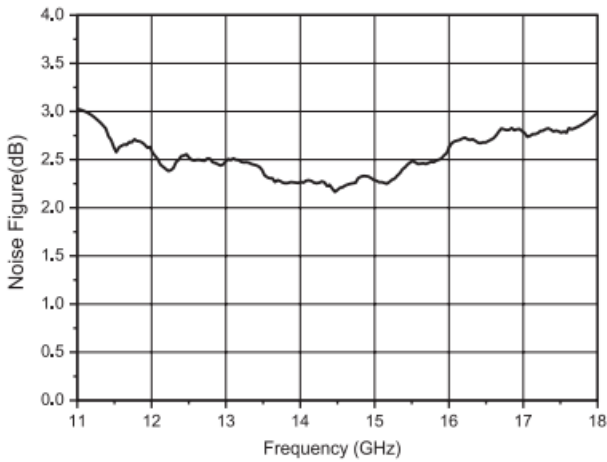
S_Parameter vs. Frequency



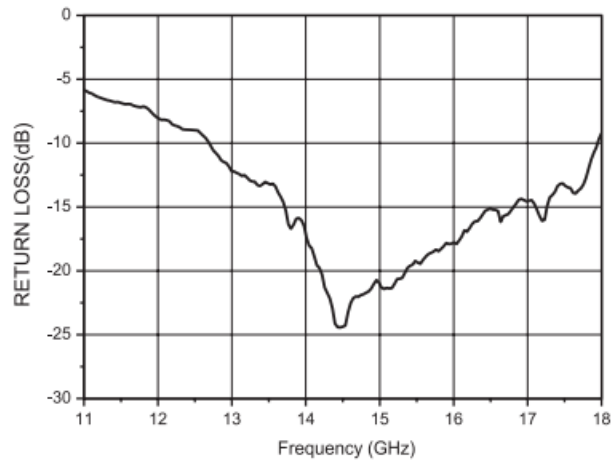
Gain vs. Frequency



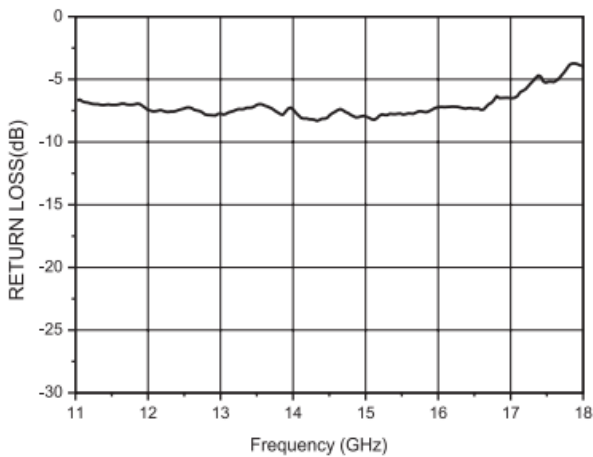
Noise Figure vs. Frequency



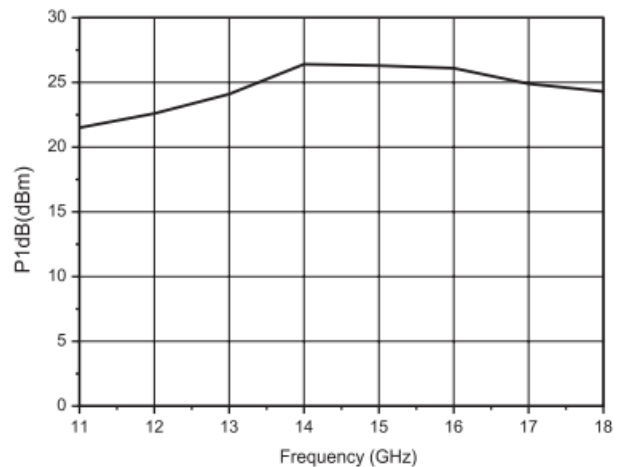
Input Return Loss vs. Frequency



Output Return Loss vs. Frequency

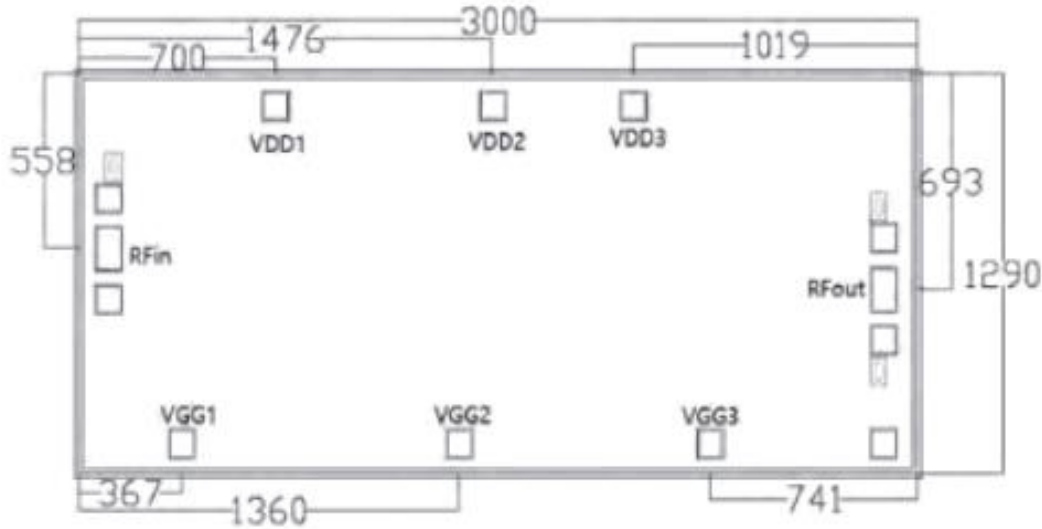


P-1dB vs. Frequency





Outline Drawing:
All Dimensions in um

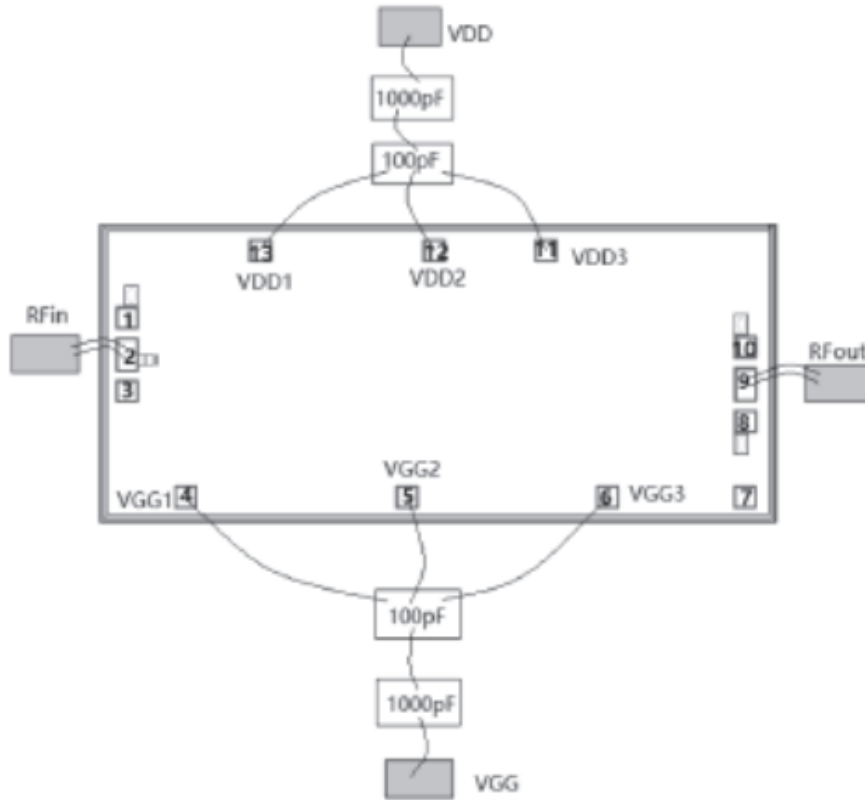


Pad Description

PAD	Function	Description
1,3,7,8,10	GND	Die bottom must be connected to RF/DC ground
2	RF IN	RF signal input terminal, external 50-ohm system required
9	RF OUT	RF signal output terminal, external 50-ohm system required
11,12,13	Vdd	Amplifier drain power supply, external 100pF capacitor required
4,5,6	Vgg	Amplifier gate power supply, external 100pF capacitor required



Assembly Drawing



Notes:

1. Die thickness: 100um
2. Typical bond pad is 100*100 μm^2
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

Maximum Ratings:

1. Supply voltage: +5.5V
2. RF input power: 10dBm
3. Operating temperature: -55°C to +85°C
4. Storage temperature: -65°C to +150°C